

### **Test Instruments for Measuring Electrical Safety of Devices** per VDE 0701-0702, IEC 62353 and IEC 60974-43

3-349-753-03 21/6.19

- Preconfigured test sequences for quickly testing simple operating equipment
- One universal, adjustable test sequence
- One test sequence executed with individual measurements
- Suitable for use by instructed persons
- Enormous data maintenance and storage concept for automated test sequences and measurements for up to 50,000 data records
- Fast access to measurement and test functions with double rotary switch, direct selection keys and softkeys
- High-resolution, brilliant 4.3" TFT color display
- Unique multiple measurement allows convenient recording of several measuring points.
- Automatic DUT connection and protection class detection
- Compact, impact resistant housing with integrated rubber protector
- Comprehensive, legally secure preparation of test reports
- Modern interfaces: for data entry (two USB A) and data exchange (one USB B)
- Extensive setting options for international use (language, keyboard, character set, date, time)
- Testing of PRCDs of PRCD standard type, SPE-PRCD, PRCD-S and PRCD-K within test sequences in accordance with DIN VDE 0701-0702-PRCD.















### Database Expansions for SECUTEST DB+ (Z853R) (as of firmware 2.2.1)

- Remote control via PC software (IZYTRONIQ) possible.
- Additional database elements for property, building, floor and room for a better structuring of large data volumes and additional fields for department and cost center
- Multiprint print-out of several / all test reports (to a connected Z721S thermal printer) which are available for a device under test by pressing just one key
- Create user-defined report templates and manage them in the SECUTEST, including company logo
- Data export of all data (master data and measured values) as a file to a USB flash drive
- Data import of all DUT master data (except measured values) from IZYTRONIQ or a USB flash drive into the SECUTEST
- Create user-defined test sequences in IZYTRONIQ and upload them to the SECUTEST
- New database field test interval (also for the synchronization with IZYTRONIQ)

### Database Expansions for SECUTEST DB COMFORT (Z853S)

- New database object Medicine Device with extended entry options
- The search function via the "Search all" softkey now also allows for searching in the new field "UDI" (Unique Device Identification) of medical devices.
- User-defined test sequences the number of user-defined sequences has now been increased to 24
- Shifting of test objects the "shifting" of a (medical) device within the tree can be initiated by pressing and holding onto the tree symbol in the main display.
- Touchedit the "editing" of a (medical) device can be opened by pressing and holding onto the detailed view in the main display.
- Autostore the Autostore function can be activated in the setup so that test results of the automatic test can be stored immediately under the selected test object.
- PushPrint A PC connected with the test instrument can put the SECUTEST in another operating mode in which the data are sent directly to the connected PC instead of saving them.
- QuickEdit When entering a new DUT, the QuickEdit option can be activated, thus enabling the user to enter all other fields in one go after entry of the ID numbers.
- New database field **Test interval** (as of version 2.0.0 also for synchronization with IZYTRONIQ)

### **Test Instruments for Measuring Electrical Safety of Devices**

### Overview of Features Included with SECUTEST BASE, SECUTEST PRO and SECULIFE ST BASE(25) Test Instruments

Switch Set- ting	<b>Measur</b> Test Cur	<b>ing Function,</b> rent/Voltage	Measurement Type Connection Type					
•	meagure	ments, rotary switch level: green	Connoction Type					
RPF	R <sub>PE</sub>	Protective conductor resistance	DE/TC) D1 possivo					
NPE	I I	Test current (200 mA)  SECUTEST BASE10/PRO: and SECULIFE ST BASE 10 A <sup>1</sup> (Feature G01) & SECULIFE ST BASE25: 25 A <sup>1)</sup> (Feature G02)	PE(TS) - P1 passive PE(TS) - P1 active PE(Mains) - P1 PE(Mains) - P1 Clamp <sup>2</sup> P1 - P2 <sup>3</sup>					
RIS0	N <sub>ISO</sub>	Insulation resistance Test voltage	LN(TS) - PE(TS) LN(TS) - P1 P1 - P2 <sup>3</sup> PE(Mains) - P1 PE(TS) - P1 LN(TS) - P1//PE(TS)					
ĪPE	I <sub>PE</sub>	Protective conductor current, RMS value	Direct					
	I <sub>PE</sub> - U <sub>LN</sub>	AC component DC component Test voltage	Differential Alternative AT3-Adapter <sup>2</sup> Clamp <sup>2</sup>					
lв	I <sub>T~</sub> I <sub>T~</sub> I <sub>T=</sub> U <sub>LN</sub>	Touch current, RMS value AC component DC component Test voltage	Direct Differential Alternative (P1) Permanent connection Alternative (P1–P2)					
IG	I <sub>E</sub> ~ I <sub>E</sub> ~ I <sub>E</sub> = U <sub>LN</sub>	Device leakage current, RMS value AC component DC component Test voltage	Direct Differential Alternative AT3-Adapter <sup>2</sup> Clamp <sup>2</sup>					
IA	I <sub>A≃</sub> U <sub>A</sub>	Leakage current from the application part, RMS value Test voltage	Direct (P1) Alternative (P1) Permanent conn. (P1)					
<b>I</b> P	I <sub>P</sub> <u>~</u> I <sub>P</sub> <sub>~</sub> I <sub>P</sub> <sub>−</sub> U <sub>I N</sub>	Patient leakage current, RMS value AC component DC component Test voltage	Direct (P1) Permanent conn. (P1)					
U	U <u>~</u> U <sub>~</sub> U <sub>=</sub>	Probe voltage, RMS Alternating voltage component Direct voltage component	PE - P1 PE - P1 (with mains*) * polarity preset					
	U <u>~</u> U <sub>~</sub> U <sub>=</sub>	Measurement Voltage RMS <sup>2</sup> Alternating voltage component <sup>2</sup> Direct voltage component <sup>2</sup>	V – COM V – COM (with mains)					
ta <sup>4</sup>	$t_B$	PRCD time to trip for 30 mA PRCDs Line voltage at the test socket						
P		n test at the test socket  Current between L and N  Voltage between L and N  Frequency  Active power  Apparent power  Power factor	Polarity preset					
Probe measuring functions								
EL1	Extension continuity	ocords with adapter: , short-circuit, polarity (wire reversal <sup>5</sup> )	EL1 adapter AT3-IIIE adapter VL2E adapter					
EXTRA	Reserved °C IZ	for expansion during the course of software Temperature measurement <sup>2</sup> with Pt100/Pt1000 Measurement of current at clamp with current clamp sensorn						

- 10 A/25 A-R<sub>PE</sub> measurements are only possible with line voltages of 115/230 V and line frequencies of 50/60 Hz.
- Voltage mesurement inputs only with SECUTEST PR0 (or device with Feature I01) and SECULIFE ST BASE(25)
- <sup>3</sup> Terminal for 2<sup>nd</sup> test probe for 2-pole measurement only with SECUTEST PR0 (or device with Feature H01) and SECULIFE ST BASE(25)
- Measurement of time to trip not possible in IT systems
- No checking for reversed polarity takes place when the EL1 adapter is used.

#### Key

P1

Alternative = alternative measurement

(equivalent leakage current measurement)

Differential = differential current measurement

Direct = direct measurement

LN(TS) = short-circuited conductors L and N of test socket

= measurement with test probe P1

P1-P2 = 2-pole measurement with test probe P1 & P2 PE-P1 = measurement between PE and test probe P1

PE(TS) = protective conductor of test socket PE(Mains) = protective conductor of mains terminal

Switch Setting	Standard	Measurement Type, Connection Type
Automate	ed test sequences, roa	tary switch level: orange
Preconfig	jured (freely configura	able) test sequences – Delivery Status
A1	VDE 0701-0702	Passive measuring method, test socket
A2	VDE 0701-0702	Active measurement type, test socket
A3	VDE 0701-0702-IT	Parameters configuration for EDP (active)
A4	IEC 62353 (VDE 0751)	Passive measurement type
A5	IEC 62353 (VDE 0751)	Active measurement type
A6	IEC 60974-4	Connection type: test socket
A7	IEC 60974-4	Connection type: AT16-DI/AT32-DI
A8	VDE 0701-0702	VDE 0701-0702, measurement type Extension Cord test (RPE, RISO), EL1/VL2E/AT3-IIIE adapter
AUT0	VDE 0701-0702	Active measurement type, test socket

#### **Overview of Differences in Features**

SECUTEST	Feature	BASE	PR0	PRO BT comfort	_
SECULIFE		_	ST BASE	_	ST BASE 25
Touch screen / keyboard	E01		•	•	•
10 A RPE test current	G01		•	•	
25 A RPE test current	G02				•
2 <sup>nd</sup> test probe	H01		•	•	•
Voltage meas. inputs*	101		•	•	•
SECUTEST DB+	KB01		•	•	•
SECUTEST DB comfort	KD01			•	•
Bluetooth®	M01			•	
Antimicrobial housing	_		ST BASE		•

for voltage measurements or connecting current clamp sensors or AT3 adapter as well as for temperature measurement via RTD

#### Display with Selectable Language

The display panel consists of a backlit, color multi-display at which menus, setting options, measurement results, instructions and error messages, as well schematic and wiring diagrams appear.

The display and user prompting can be set to the desired language depending on the country in which the test instrument is used.

### **Data Entry**

Data can be entered, for example, via a barcode reader connected to the USB port, a RFID scanner, a USB keyboard, or via the softkey keyboard when it appears at the display.

The touch screen of **SECUTEST PRO** (or devices with Feature E01) and **SECULIFE ST BASE(25)** allows for the convenient entry of data and comments while menu control is still based on softkeys.

### **Test Instruments for Measuring Electrical Safety of Devices**

#### Creating a Database

A complete test structure with data regarding customers, buildings\*, floors\*, rooms\* and test objects can be created in the test instrument. This structure makes it possible to assign single measurements or test sequences to devices under test belonging to various customers. Manual single measurements can be grouped together into a so-called "manual sequence".

The SECUTEST PRO and SECULIFE ST BASE(25) test instruments and those instruments with database expansion (Feature KB01) enable the user to prepare a test structure by means of the IZYTRONIQ software at the PC for subsequent transmission to the test instrument.

#### **Data Interfaces**

Structures set up in, and measurement data saved to the test instrument can be imported to **IZYTRONIQ** report generating software via the USB slave port. Data can then be archived at the PC, comments can be added with the software and reports can be generated.

The following input and output devices can be connected to the two integrated USB master ports:

- An external keyboard and a barcode or RFID reader,
- USB stick for data backup, import, export and reporting
- A printer

#### Software Update

The test instrument can always be kept current thanks to firmware which can be updated via the USB slave port.

### **Report Generating Functions**

All of the values required for approval reports or device logbooks for electrical equipment (e.g. per ZVEH) can be measured with this instrument. The measured data can be documented and archived thanks to the measurement and test report that can be printed with a thermal printer connected to the USB port, or stored to a PC.

### **Automatic Detection of Measuring Point Changes**

During protective conductor measurement, the test instrument recognizes whether or not the test probe is in contact with the protective conductor, which is indicated by means of two different acoustic signals. This function is very useful where several protective conductor connections need to be tested.

### **Mains Connection Analysis**

Line voltage and frequency are measured and compared with the data specified in the setup menu. Momentary voltage or nominal voltage in accordance with the standard is required, for instance in order to extrapolate measured values for the leakage current measurement.

### **Automatic Detection of Mains Connection Errors**

The device automatically recognizes mains connection errors if the conditions in the following table have been fulfilled. The user is informed of the type of error, and all measuring functions are disabled in the event of danger.

Type of Connection Error	Message	Condition	Measurements
Voltage at protective conductor PE to fin- ger contact (START/ STOP key)		Press <b>START</b> /STOP button U > 25 V Button $\rightarrow$ PE: < 1 M $\Omega$ <sup>2</sup>	All measurements disabled

Type of Connection Error	Message	Condition	Measurements
Protective conductor PE & phase conductor L reversed and/or neutral conductor N interrupted		Voltage at PE > 100 V	Impossible (no supply power)
Line voltage < 180 V / < 90 V (depending on mains)		$\begin{array}{c} U_{L-N} < 180 \text{ V} \\ U_{L-N} < 90 \text{ V} \end{array}$	Possible under certain circumstances <sup>1</sup>
Test on IT/TN system	Display at the instrument	Connection $N \rightarrow PE > 20 \text{ k}\Omega$	Possible under certain circumstances

<sup>10</sup> A/25 A-R<sub>PE</sub> measurements are only possible with line voltages of 115/230 V and line frequencies of 50/60 Hz.

### **Analysis of DUT Connection and Condition**

Depending on the measurement or how the DUT is connected, the following states are checked and displayed before measurement is begun

	d and displayed before measure	
Control Function		Condition
Short-circuit test L-N	Short-circuit / starting current	$R \le 2.5 \Omega^2$
	No short-circuit (AC test)	$R > 2.5 \Omega^2$
Open-Circuit Voltage U <sub>0</sub> 4.3 V,	Short-Circuit Current I <sub>K</sub> < 250 mA	
Short-circuit test N-PE	Short-circuit	$R \le 2 k\Omega$
	No short-circuit (AC test)	$R > 2 k\Omega$
Open-Circuit Voltage U <sub>0</sub> 230 V,	AC, Short-Circuit Current I <sub>K</sub> < 1.5 mA	
On test	On (passive DUT)	$R < 250 \text{ k}\Omega$
	Off (active DUT)	$R > 300 \text{ k}\Omega$
Open-Circuit Voltage U <sub>0</sub> 230 V A	AC, Short-Circuit Current I <sub>K</sub> < 1,5 mA	
Special test	No probe	$R > 2 M\Omega$
	Probe detected	$R < 500 \text{ k}\Omega$
Protection class detection (on	ly for country-specific (earth-contact) plu	ug variant)1
	Protective conductor exists: PC I	$R < 1 \Omega$
	No protective conductor: PC II	$R > 10 \Omega$
Safety shutdown		
Triggered at following residual	current value (selectable)	> 10 mA / > 30 mA
Triggered at following residual	current values (selectable)	
	uring leakage current measurement	> 10 mA
	otective conductor resistance meas.	> 250 mA
Connection test (only for cour	try-specific (earth-contact) plug varian	t) <sup>1)</sup>
Checks whether the DUT is co	nnected to the test socket.	
	Power line of DUT exists	R < 1 Ω
	No power line of DUT	$R > 10 \Omega$
Insulation test		
	JT set up in a well-insulated fashion	$R \ge 500 \text{ k}\Omega$
	set up in a poorly insulated fashion	$R < 500 \text{ k}\Omega$
PELine – PETestsocket: Open-C	ircuit Voltage U $_0$ 500 V DC $^3$ , I $_{\rm K}$ $<$ 2 mA	
Overcurrent protection (shutd	own)	
Our test instruments SECUTEST E		I > 16.5 A
BASE(25) allow for the active test current) of up to 16 A. The test so equipped with 16 A fuses and the also amounts to 16 A. Starting cu devices under test which are expe	ing of devices with a nominal current (load backet of the respective test instrument is a switching capacity of the internal relays rrents of up to 30 A are permissible. For exted to feature a starting current of more ad the application of a test adapter for	
1) applies to M7050 with fe	-t DOO DOO	

<sup>1)</sup> applies to M7050 with feature B00, B09

only with SECUTEST PRO or with database expansion (Feature KB01) and SECULIFE ST BASE(25)

<sup>2</sup> if the test person is highly insulated, the following error message may appear: "Interference voltage at PE of mains connection"

applies as from version 1.7.0; previous condition  $\leq$  1.5  $\Omega$  or > 1.5  $\Omega$ , respectively

 $<sup>^{3)}</sup>$  50 V DC as from version 2.1.0

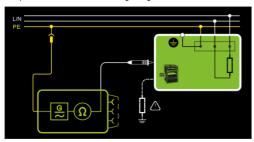
### **Test Instruments for Measuring Electrical Safety of Devices**

### **Backlit Multi-Display Samples**

Single Test - Initial Screen with Parameters Display



Help - Schematic and Wiring Diagram



Test Function for Test Step in the Test Sequence



Results of a Test Sequence per VDE 0701-0702



Database Structure - List of Test Results



### **Scope of Delivery**

#### Standard version (country-specific)

- 1 SECUTEST BASE, SECUTEST PRO or SECULIFE ST BASE(25) test instrument
- 1 Mains power cable
- 1 Test probe, 2 m, not coiled
- 1 USB cable, USB A to USB B, 1.0 m long
- 1 Plug-on alligator clip
- 1 KS17-ONE cable set for voltage measuring inputs (only with SECUTEST PR0 or devices with Feature I01) and SECULIFE ST BASE(25)
- 1 Calibration certificate
- 1 Condensed operating instructions D, GB
- Detailed operating instructions available on the Internet at www.gossenmetrawatt.com
- 1 Card with registration key for software



### List of Software Variants depending on Device Type

IZYTRON JQ		Soft Varia	ware ants	
	Article number	BUSINESS Starter	<b>BUSINESS Advanced</b>	<b>BUSINESS Professional</b>
Standard Models				
SECUTEST BASE IQ	M705A	•		
SECUTEST PRO IQ	M705C	•		
SECUTEST PRO BT comfort IQ	M705E	•		
SECULIFE ST BASE IQ	M694A	•		
SECULIFE ST BASE 25 IQ	M694B	•		
Device Sets				
STARTER PACKAGE SECUTEST BASE IQ	M706A		•	
MASTER PACKAGE DB+ IQ	M706D			•
PROFI PACKAGE SECUTEST PRO IQ	M706M			•
COMFORT PACKAGE SECUTEST PRO IQ	M706V			•
WELDING PACKAGE SECUTEST PRO IQ	M706P			•
3-PHASE CURRENT PACKAGE SECUTEST PRO IQ	M706S			•

**IZYTRONIQ** is a test software that has been newly developed from scratch. It enables the user to visualize and manage the entire testing procedure for all our test instruments and to document it in an audit-proof manner. For the first time, it is thus possible to combine the test and measurement data from a great variety of test instruments and multimeters in one test and generate one report report thereof. The intuitive user guidance and modern design provide for quick access to all functions.

The software is available in different sizes and versions for trades, industry and vocational training purposes.

# SECUTEST BASE / PRO and SECULIFE ST BASE(25) Test Instruments for Measuring Electrical Safety of Devices

### **Characteristic Values**

Func-	Measured	Display Range / Nominal Range of	Reso-	Nominal Voltage	Open- Circuit	Nom. Current	Short- Circuit Current	Inter- nal Resis-	Refer- ence Resis-	Measuring	Intrinsic Error	Over Capa	load acity
tion	quantity	Quantity Use	lution	U <sub>N</sub>	Voltage U <sub>0</sub>	I <sub>N</sub>	Current I <sub>K</sub>	tance R <sub>I</sub>	tance R <sub>REF</sub>	Uncertainty		Value	Time
	Protective	1 999 mΩ	1 mΩ		< 24 V		>200 mA AC or DC >10 A AC 5			±(15% rdg. + 10 D)	±(10% rdg.+ 10 d)	264 V 250 mA	Cont.
	conductor resistance <sup>12</sup>			_	AC or DC	_		_	_	> 10.0 Ω:	> 10 d	16 A <sup>5</sup>	
51)	RPE	1.00 999 Ω	10 mΩ				>35 AAC			±(10% rdg.+ 10 d)		>42 AAC	15 s
E 07		10.0 30.0 Ω	100 mΩ										
Ŋ.	Insulation	10 999 kΩ	1 kΩ							±(5% rdg.+ 4 d)	±(2.5% rdg.+2 d)		
53	resistance 9	1.00 9.99 MΩ	10 kΩ	50 500		> 1 mA	> 2 mA	_	_	> 10 d	> 10 d	264 V	Cont.
623	Riso	10.0 99.9 MΩ	100 kΩ	V DC	1.5 • U <sub>N</sub>					≥ 20 MΩ:	≥ 20 MΩ:		
Ë		100 300 MΩ	1 ΜΩ							±(10% rdg.+ 8 d)	±(5% rdg.+4 d)		
[	Leakage current,	0.0 99 μΑ	1 μΑ		50					1/50/ rdg + 4 d/ > 10 d	±/20/ rdg + 2 d\ > 10 d		
702	alternative	100 999 μΑ	1 μΑ	_	250 V~	_	> 1.5 mA	> 150 kΩ	1 kΩ	±(5% rdg.+ 4 d) > 10 d > 15 mA:	±(2% rdg.+2 d) > 10 d > 15 mA:	264 V	Cont.
7-0	measurement <sup>2</sup>	1.00 9.99 mA	10 μΑ		- 20/+10%				±10 Ω	±(10% rdg.+ 8 d)	±(5% rdg.+ 4 d)		
070	IFE, ID, IU, IA	10.0 30.0 mA	100 μΑ										
Tests, 62638 (DIN VDE 0701-0702) / IEC 62353 (VDE 0751)	Leakage current,	Only lp: 0.0 99.9 μΑ	100 nA										
	direct	0.0 99 μΑ	1 μΑ					1 kΩ	1 kΩ	±(5% rdg.+ 4 d)	±(2.5% rdg.+2 d)	264 V	Cont
338	measurement <sup>3</sup>	100 999 μΑ	1 μΑ	_	_	_	_	±10 Ω	1 KS2	> 10 d	> 10 d	204 V	Cont.
929	IPE, IB, IG, IA, IP	1.00 9.99 mA	10 μA										
sts,		10.0 30.0 mA	100 μΑ										
ě	Leakage current,	0 99 μΑ	1 μΑ										
	differential	100 999 μΑ	1 μΑ			_   _	_   _	-   _	_   _	±(5% rdg.+ 4 d) > 10 d	±(2.5% rdg.+2 d) > 10 d	264 V	
	current measurement <sup>4</sup>	1.00 9.99 mA	10 μA	_	_								Cont.
	IPE, IB, IG	IPE, IB, IG 10.0 30.0 mA 100 μA											
sket	Line voltage $U_{L-N}^{10}$	100.0 240.0 V~	0.1 V	_	_	_	_	_	_	_	±(2% rdg.+2 d)	264 V	Cont.
300	Load current I <sub>L</sub>	0 16.00 A <sub>RMS</sub>	10 mA	_	_	_	_	_	_	_	±(2% rdg.+2 d)	16 A	Cont.
test	Active power P	0 3700 W	1 W								±(5% rdg.+10 d)	264 V	Cont.
t at	Active power P	0 3700 W	I VV	_	_	_	_	_	_	_	> 20 d	20 A	10 min
on tes	Apparent power S	0 4000 VA	1 VA			Cald	culated valu	e, U <sub>L-N</sub> • I <sub>V</sub>	,		±(5% rdg.+10 d) > 20 d	264 V	Cont.
Function test at test socket	Power factor PF with sinusoidal waveform: coso	0.00 1.00	0.01			Calculated	I value, P /	S, display >	· 10 W		±(10% rdg.+5 d)	264 V	Cont.
	Line frequency	0 420.0 Hz	0.1 HZ	_	_	_	_	_	_	_	±(2% rdg.+2 d)	264 V	Cont.
t <sub>A</sub>	Time to trip	0.1 999 ms	0.1 ms	_	_	30 mA	_	_	_	±5 ms	_	264 V	Cont.
PRCD	Probe voltage	0.0 00.01/											
ent	(test probe P1 to PE)	0.0 99.9 V						3 MΩ			±(2 % v.M.+2 D)	264 V	
rem	, ~ and ≂	100 264 V						02			_(= /0 11111 / 2 5)	2011	
Voltage measurement	Measurem. voltage	0,0 99.9 V	100 mV	_	_	_	_			_	±(2 % rdg. +2 d) > 45 Hz 65 Hz	300 V	Cont.
ige	(sockets V–COM <sup>6</sup> )	0,0 00.0 ¥	1 V					1 MΩ			±(2 % rdg.+5 d)	==, ~	
Volta	=, $∼$ and $≂$	100 300 V									> 65 Hz 10 kHz ±(5 % rdg. +5 d) > 10 kHz 20 kHz	and ≂	
	Leakage current	0,00 0.99 mA ∼	0.01 mA										
ΙL	via AT3-IIIE	1,0 9.9 mA ∼	0.1 mA	_	_	_	_	_	_	_	±(2 % rdg.+2 d) > 10 D	253 V	Cont.
-L	adapter Z745S <sup>6</sup> <sup>8</sup>	10 20 mA ∼	1 mA								without adapter		
	Temperature		i IIIA										
Temp	with Pt100 sensor	− 200.0 +850.0 °C	0.1 °C	_	< 20 V -		1.1 mA	_	_	_	±(2 % rdg.+1 °C)	10 V	Cont.
•	Temperature with Pt1000 sensor	− 150.0 +850.0 °C											

## **Test Instruments for Measuring Electrical Safety of Devices**

Func-	Measured Display Range / Nominal Range of		Reso-	Nominal Voltage	Open- Circuit	Nom. Current	Short- Circuit	Inter- nal Resis-	Refer- ence Resis-	Measuring	Intrinsic Error		rload acity																							
tion	Quantity	Use	lution	U <sub>N</sub>	Voltage U <sub>0</sub>	I <sub>N</sub>	Current I <sub>K</sub>	tance R <sub>I</sub>	tance R <sub>REF</sub>	Uncertainty	IIIUIIISIC EIIOI	Value	Time																							
	Current via	1 99 mA ∼	1 mA (1 mV)																																	
	current clamp sensor	0.1 0.99 A ∼	0.01 A (10 mV)	_	_	_	_	_	_	_																										
	[1 mV : 1 mA] (V-COM sockets <sup>6</sup> <sup>7</sup> )	1.0 9.9 A ∼	0.1 A (100 mV)																																	
		10 300 A ∼	1 A (1 V)																																	
	Otuda	0.1 9.9 mA ∼	0.1 mA (1 mV)				_																													
	Current via current clamp	10 99 mA ∼	1 mA (10 mV)	_				_																												
	sensor [10 mV : 1 mA] (V–COM sockets <sup>6 7</sup> )	0.10 0.99 A ∼	0.01 A (100 mV)			_			_	_																										
	(V CON SUCKCES )	1.0 30.0 A ∼	0.1 A (1 V)					±(2 % rdg.+2 d)																												
I <sub>Clamp</sub>	Ourment vie	0.01 0.99 mA ∼	0.01 mA (1 mV)						20 Hz 20 kHz	253 V	Cont.																									
	Current via current clamp sensor	1.0 9.9 mA ∼	0.1 mA (10 mV)													_							maioat olamp													
	[100 mV : 1 mA] (V–COM sockets <sup>6 7</sup> )	10 99 mA ∼	1 mA (100 mV)																																	
		0.10 3.00 A ∼	0.01 A (1 V)																																	
	Current via current clamp sensor [1000 mV : 1 mA] (V–COM sockets <sup>6</sup> /) 1 99 μΑ ~ (1 mV) 1 μΑ (10 mV) 1 mA] (V–COM sockets <sup>6</sup> /) 1 9.9 mA ~ (100 mV)																																			
		0.10 0.99 mA ∼																																		
		1.0 9.9 mA ∼		_	_	_	_	_	_	_	_	_	_	_	<u> </u>	_	_	_	_	_	_	_	_	_	_	_	_	_	_	_	_	_	_	_		
	(* OOM 3001013 )	10 300 mA ∼	1 mA (1 V)																																	

Known as equivalent leakage current or equivalent patient leakage current from previous standards

**Key:** rdg. = reading (measured value), d = digit(s)

#### Test Times, Automated Sequence

The test times (parameter "Measurement duration ...") can be adjusted in the sequence parameter setting menu for each rotary switch position separately. The test times are not tested and calibrated.

### **Emergency Shutdown During Leakage Current Measurement**

As of 10 mA of differential current (can also be set to 30 mA), automatic shutdown ensues within 500 ms. This shutdown is not effected during leakage current measurement with clamp or adapter.

### Influencing Quantities and Influence Error

Influencing Quantity / Sphere of Influence	Designation per IEC 61557-16	Influence Error $\pm \dots$ % rdg.
Change of position	E1	_
Change to test equipment supply voltage	E2	2.5
Temperature fluctuation	E3	Specified influence error valid starting with temperature changes as of 10 K:
0 40 °C		2.5
Amount of current at DUT	E4	2.5
Low frequency magnetic fields	E5	2.5
DUT impedance	E6	2.5
Capacitance during insulation measurement	E7	2.5
Waveform of measured current		
49 51 Hz	E8	2 with capacitive load (for equivalent leakage current)
45 100 Hz		1 (for touch current)
		2.5 for all other measuring ranges

Protective conductor current, touch current, device leakage current, patient leakage current Protective conductor current, touch current, device leakage current

Only with feature IO1, p. e. SECUTEST BASE10/SECUTEST PRO and SECULIFE ST BASE Only with feature IO1, p. e. SECUTEST PRO and SECULIFE ST BASE

Measurement type IPE clamp and IG clamp

Measurement type IPE AT3 adapter and IG AT3 adapter

The measuring range upper limit depends on the selected test voltage.
Due to inrush current limiting components, the voltage at the test socket may be lower than the measured line voltage

<sup>11)</sup> only with feature G02, p. e. **SECULIFE ST BASE25** 

<sup>12)</sup> Details for measurement type PE(mains) – P1 after offset balancing

### **Test Instruments for Measuring Electrical Safety of Devices**

Reference Ranges

 $\begin{array}{ll} \mbox{Line voltage} & 230 \mbox{ V AC } \pm 0.2\% \\ \mbox{Line frequency} & 50 \mbox{ Hz } \pm 2 \mbox{ Hz} \\ \end{array}$ 

Waveform

Sine (deviation between effective and rectified value < 0.5%)

 $\begin{array}{lll} \mbox{Ambient temperature} & +23 \ \mbox{°C} \ \pm 2 \ \mbox{K} \\ \mbox{Relative humidity} & 40 \dots 60\% \\ \mbox{Load resistance} & \mbox{Linear} \end{array}$ 

**Nominal Ranges of Use** 

Nominal line voltage 100 V ... 240 V AC Nominal line frequency50 Hz ... 400 Hz Line voltage waveform Sinusoidal Temperature 0 °C ... + 40 °C

**Ambient Conditions** 

Storage temperature -20 °C ... +60 °C

Relative humidity Max. 75%, no condensation allowed

Elevation Max. 2000 m

Deployment Indoors, except within specified ambient

conditions

**Power Supply** 

Electrical system TN, TT or IT
Line voltage 100 V ... 240 V AC
Line frequency 50 Hz ... 400 Hz

Power consumption 200 mA test: approx. 32 VA 10 A test: approx. 105 VA

Mains to test socket

(e. g. function test) Continuous max. 3600 VA, power is con-

ducted through the instrument only, switching capacity ≤ 16 A, ohmic load; for currents > 16 A AC please use the

adapter AT3-IIS32 (Z745X)

**Electrical Safety** 

Fuse links

Nominal voltage 230 V

Test voltage 2.3 kV AC 50 Hz or 3.3 kV DC

(mains circuit / test socket to mains PE terminal, USB, finger contact, probe, test socket)

Measuring category 250 V CAT II

Pollution degree 2

Safety shutdown At DUT differential current of > 10 mA,

shutdown time: < 500 ms, can also be set to > 30 mA with following probe current during:

Leakage current meas.:> 10 mA~/< 500 ms</li>

- Protective conductor resistance meas.:

> 250 mA~/< 1 ms

At continuous flow of current I > 16,5 A Mains fuses: 2 ea. FF 500V/16A

Probe fuse: 2 ea. FF 500V/16A Probe fuse: M 250V/250mA

SECUTEST BASE10/PR0/ SECULIFE ST BASE: Additionally (Feature G01)

10 A RPE test current 1 ea. FF 500V/16A

Bluetooth<sup>®</sup> 2.1 + EDR Data Interface (SECUTEST PRO BT comfort only or feature M01) **USB Data Interface** 

Type USB slave for PC connection

Type 2 ea. USB master for data input devices\*

with HID-Boot interface, for USB stick for data backup,

for USB stick for storing reports as bmp

files, for printer\*

\* compatible devices see next page

**As of firmware version 1.6.0:** In the remote operating mode, the test instrument can be controlled via the USB slave data interface.

#### **Electromagnetic Compatibility**

Product standard DIN EN 61326-1:2013 DIN EN 61326-2-2:2013

Interference Emission		Class
EN 55011		В
IEC 61000-3-2		В
IEC 61000-3-3		В
Interference immunity	Prüfwert *	<b>Evaluation criterion</b>
EN 61000-4-2	Contact/atmos 4 kV/8 kV	В
EN 61000-4-3	10 V/m (80 MHz 1 GHz)	А
EN 61000-4-4	Mains connection - 2 kV	В
EN 61000-4-5	Mains connection 1 kV (LN), 2 kV (LPE)	В
EN 61000-4-6	Mains connection 3 V	А
EN 61000-4-8	30 A/m	А
EN 61000-4-11	0%: 1 period	В
	0%: 250/300 periods	С
	40%: 10/12 periods	С
	70%: 25/30 periods	С

Mechanical Design

Display 4.3" color display  $(9.7 \times 5.5 \text{ cm})$ ,

backlit, 480 x 272 pixels at 24 bit color

depth, (true color)

Touch screen with SECUTEST PRO/SECULIFE ST BASE(25)

or feature E01

Height with handle: 170 mm

Weight SECUTEST BASE(10)/PR0: Approx. 2.5 kg

SECULIFE ST BASE25: approx. 4.0 kg

Protection Housing: IP 40

Test socket: IP 20 per DIN VDE 0470,

part 1/EN 60529,

**SECULIFE ST BASE(25)**: Housing with antimicrobial properties in accordance with the JIS-

Standard Z 2801:2000

### Regulations and standards in accordance with which the test instrument is manufactured and tested:

DIN EN 61010-1:2011 VDE 0411-1:2011	Safety requirements for electrical equipment for measurement, control and laboratory use — General requirements
DIN EN 60529/ VDE 0470, part 1	Test instruments and test procedures Degrees of protection provided by enclosures (IP code)
DIN EN 61326-1 VDE 0843-20-1	Electrical equipment for measurement, control and laboratory use – EMC requirements – Part 1: General requirements
DIN EN 61326-2-2 VDE 0843-20-2-2	Part 2-2: Particular requirements – Test configurations, operational conditions and performance criteria for portable test, measuring and monitoring equipment used in low-voltage distribution systems
IEC 61557-16 DIN EN 61557-16 VDE 0413-16	Electrical safety in distribution systems up to 1000 V a.c and 1500 V d.c – Equipment for testing, measuring or monitoring of protective measures - Part 16: Equipment for testing the safety of electrical equipment and medical electrical equipment

### **Test Instruments for Measuring Electrical Safety of Devices**

### Accessories (not included)

#### **Z751A Barcode Reader**

For connection to the USB master port at the test instrument, and for reading in barcodes. This makes it possible to conveniently insert the ID numbers of DUTs into single measurements and test sequences.

This device is based upon the concept of an instinctive scanning distance and provides best possible reading performance. Green Spot technology provides a "good-read" projection directly on the code. The device is equipped with a USB port.



#### Barcode printer Z721E

For connection to the USB master port at the test instrument, and for printing out barcode labels.

Coding: Code39, Code128, EAN13, Text, QR Code\*, Micro QR Code, DataMatrix, Aztec

\* QR Code is a registered trademark of DENSO WAVE INCORPORATED



### **Z721S Thermal Printer**

For connection to the USB master port at the test instrument, and for printing out test reports.



#### SCANBASE RFID (Z751E) (RFID read / write)

Compact write/read device with USB interface for programming and reading of 13.56 MHz transponders per ISO 15693.

SECUTEST BASE10/PR0/SEC-ULIFE ST BASE(25) enable the user to populate the RFID tags direcly from the test instrument with the help of the programmer.



### CEE Adapter (Z745A) for Testing Single and 3-Phase Electrical Devices

The Z745A CEE adapter allows for quick and efficient testing of devices equipped with a CEE plug. The adapter is equipped with the following CEE flush-type socket outlets: 5-pole 16 A, 5-pole 32 A and 3-pole 16 A. Furthermore, the adapter includes five 4 mm safety sockets to which 3-phase devices without permanently attached plug or conventional measurement cables can be connected, e.g. by means of quick clamp terminals (not included). The following tests can be performed on devices with CEE plugs with the help of the adapter:

- Testing of protective conductor continuity
- Insulation resistance, alternatively leakage current (equivalent leakage current)
- Function test (3-pole CEE outlet only)

The Z745A CEE adapter may also be used as an adapter for connecting devices with 3-pole CEE plugs to common earthing contact outlets.

### VL2 E (Z745W)

Test adapter with single-phase and 3-phase plug connectors up to CEE 32A



#### AT16-DI (Z750A) 3-Phase 16 A Differential Current Adapter

Devices which are equipped with a 5-pole, 16 A / 6 h CEE plug can be quickly and efficiently tested with the AT16-DI CEE adapter.

The following tests can be performed on devices with CEE plugs with the help of the AT16-DI CEE adapter:

- A AND STATE OF THE PARTY OF THE
- Testing of protective conductor continuity
- Insulation resistance, alternatively leakage current (equivalent leakage current)
- Measurement of protective conductor resistance with the following methods: equivalent leakage current / differential current / direct
- Function test

This differential current adapter is also available in a variant with a 5-pole 32 A / 6 h CEE plug with the designation AT32-DI CEE adapter.

### **Test Instruments for Measuring Electrical Safety of Devices**

### SECU-cal 10 (Z715A) Calibration Adapter

The calibration adapter is used for testing the measuring uncertainty of test instruments in accordance with DIN VDE 0701-0702 / IEC 62353 (VDE 0751). As a rule, these instruments must be tested once each year, as well as for certifi-



cation in accordance with the ISO 9000 quality standard, as set forth by accident prevention regulation DGUV provision 3 (previously BGV A3).

All limit values for the required tests per DIN VDE, as well as protective conductor resistance, insulation resistance, equivalent leakage current, differential and/or touch as well as housing leakage current, must be tested.

#### SECULOAD-N (Z745R) Test Adapter

Test Adapter for testing open-circuit voltage at welding units per IEC/EN 60974.

In combination with the test instrument, the test adapter is used for testing welding units in accor-



dance with the IEC/EN 60974-4 standard. This standard stipulates that peak values for open-circuit voltage may not exceed the limit values, regardless of the utilized settings.

SECUTEST BASE(10)/PRO/SECULIFE ST BASE(25) testing instrument includes a test sequence for testing welding instruments with this adapter.

The peak value rectifier of the SECULOAD-N uses rectifier diode 1N 4007 recommended by the standard. This diode is a power rectifier diode and, due to its design principle, only suitable for voltage sources with a low clock rate in the line frequency range or for voltage sources with conventional transformers.

### EL1 (Z723A) Adapter for Testing Single-Phase Extension Cables



### AT3-III-E (Z745S) 3-phase Current Adapter

Test adapter for active and passive testing of Single and 3-Phase Electric Devices and Extension Cables in Combination with SECUTEST... Test Instruments

Operation is simple and safe. The test adapter is connected to a 3-phase 16 A mains outlet, and to the respective test instrument. Testing is performed without reversing polarity at the



device under test, either automatically or manually, and is controlled by the test sequence of the utilized test instrument. Safety shutdown occurs if the factory preset residual current value is exceeded.

# **SORTIMO L-BOXX (Z503D)**Plastic system case Out-

side dimensions: W x H x D 450 x 255 x 355 mm Foam insert Z701D for tester and accessories, has to be ordered seperately, see below.



### Foam insert for SORTIMO L-BOXX (Z701D)



# **Test Instruments for Measuring Electrical Safety of Devices**

### Universal carrying pouch F2000 (Z700D)



Outside dimensions: W x H x D 380 x 310 x 200 mm (without buckles, handle and carrying strap)

### Universal carrying pouch (large) F2020 (Z700F)



Outside dimensions:
W x H x D
430 x 310 x
300 mm
(without buckles, handle and carrying strap)

### Universal carrying pouch (small) F2010 (Z700G)



Outside dimensions: W x H x D 380 x 230 x 270 mm (without carrying strap)

# SECUTEST BASE / PRO and SECULIFE ST BASE(25) Test Instruments for Measuring Electrical Safety of Devices

### **Order Information**

### SECUTEST BASE, SECUTEST PRO, SECULIFE ST BASE and SECULIFE ST BASE 25 Standard Models

Standard Model	Article Number	Features			
SECUTEST BASE IQ	M705A	Schuko variant (test socket and mains plug), selectable user interface language (default setting: German), protective conductor test current: 200 mA, (features differing from 00: AA01 V01)			
SECUTEST PRO IQ	M705C	same design as M705A, additionally with 10 A RPE test current, with touch screen, voltage measuring inputs, sockets für 2 <sup>nd</sup> test probe and database expansion DB+ (features differing from 00: AA03 E01 G01 H01 I01 KB01 V01)			
SECUTEST PRO BT comfort IQ	M705E	same design as M705C, additionally with Bluetooth interface and database comfort (features differing from 00: AA03 E01 G01 H01 I01 KB01 KD01 M01 V01)			
Scope of Delivery for each tester: Mains power cable, test probe, USB cable, Plug-on alligator clip, printed condensed operating instructions in German, complete operating instructions are complete operating instructions.					

Scope of Delivery for each tester: Mains power cable, test probe, USB cable, Plug-on alligator clip, printed condensed operating instructions in German, complete operating instructions (for download from the Internet), DAKKS calibration certificate in D-GB-F, card with registration key for PC Data base and Report software IZYTRONIQ BUSINESS Starter (scope of supply for download from the Internet)

### Order Information on Device Kits

Туре	Designation							Article Number
Starter Package SECUTEST BASE IQ	Scope of delivery see below including IZYTRONIQ BUSINESS ADVANCED							M706A
Master Package DB+ IQ	Scope of delivery see below including IZYTRONIQ BUSINESS PROFESSIONAL						M706D	
Profi Package SECUTEST PRO IQ	Scope of delivery see below including IZYTRONIQ BUSINESS PROFESSIONAL							M706M
Comfort Package SECUTEST PRO IQ	Scope of delivery see below including IZYTRONIQ BUSINESS PROFESSIONAL							M706V
Welding Package SECUTEST PRO IQ	Scope of delivery see below including IZYTRONIQ BUSINESS PROFESSIONAL							M706P
3-PHASE CURRENT PACKAGE SECUTEST PRO IQ	Scope of delivery see below including IZYTRONIQ BUSINESS PROFESSIONAL				M706S			
Accessories	For use in combination with the following testing packages:	Starter Package	Master Pack. DB+	Profi Package	COM- FORT PACKAGE	Welding Package	3-PHASE CURRENT Package	
SECUTEST BASE IQ								
SECUTEST BASE10*								
SECUTEST PRO IQ								
SECUTEST PRO BT comfort IQ								
SORTIMO L-BOXX	Plastic system case					2 x ■	2 x ■	Z503D
Foam SORTIMO L-BOXX Secutest4	Foam insert for SORTIMO L-BOXX with compartment for SECUT- EST BASE(10) or PRO		•				•	Z701D
FOAM SORTIMO L- BOXX-Adapter	Foam insert for SORTIMO L-BOXX with compartment for adapter							Z701E
EL1	Adapter for the testing of single-phase extension cables							Z723A
Brush Probe	Contact brush							Z745G
SECULOAD-N	Test adapter in combination with SECUTEST for testing welding units per DIN EN 60974-4:2007.							Z745R
Adapter AT16-DI	3-Phase 16 A Current Adapter with Residual Current Logging							Z750A
SK2	Probe cable with test probe and 2 m probe cable (not coiled)							Z745D
SK5	Probe with probe tip and 5 m probe cable (not coiled) for protective conductor measurement,							Z7450
Adapter cable CEE16/CEE32	Adapter cable CEE 16 A to CEE 32 A							Z750F
Barcode scanner	Barcode scanner for USB connection							Z751A
Thermal printer	Thermal printer for printing out test reports; including manual on CD, Lithium battery, power supply adapter, mains cable, 1 role of thermal paper			-			_	77010
	Thermal naner							Z721S

<sup>\*</sup> Database expansion DB+ included

# **Test Instruments for Measuring Electrical Safety of Devices**

SECUTEST BASE/PRO, SECULIFE ST BASE(25) (List of Order Features)

Device Variants			SECUTEST BASE (M7050 AA01 E00 G00 H00 I00 J00 KB00 M00)	SECUTEST BASE10 (M7050 AA02 E00 G01 H00 I00 J00 KB00 M00)		SECULIFE ST BASE (M7050 A01 AA11 E01 G01 H01 I01 J00 KB01 KC00 M00)	SECULIFE ST BASE 25 (M7050 A01 AA12 E01 G02 H01 I01 J00 KB01 KD01 M00)
	Article Number basic instrument				M7050		
		Article number/ Feature	AA01	AA02	4402	A A 1 1	AA40
Connections — plug fo	lary mains power supply and test socket is country-specific		AAUT	AAUZ	AA03	AA11	AA12
Connections – plug to	Germany with detection of terminals and safety classes	B00					
	UK	B01	-,-	-,-	-,-	-,-	-,-
	FR/CZ/PL	B03	-,-	-,-	_,_	-,-	-,-
			-,-	-,-	-,-	-,-	-,-
	China	B04	-,-	-,-	-,-	-,-	-,-
	USA	B05	-,-	-,-	_,_	-,-	-,-
	AUS	B06	-,-	-,-	-,-	-,-	-,-
	DK	B07	-,-	-,-	-,-	-,-	-,-
	IT	B08	-,-	-,-	-,-	-,-	-,-
	CH with detection of terminals and safety classes	B09	_,_	_,_		_,_	-,-
User interface languag	e (preset language upon delivery, can be subsequently cha		other langua	ges listed be	low)		
	German	C00	-,-	-,-	-,-	-,-	-,-
	English	C01	-,-	-,-	-,-	-,-	-,-
	French	C02	-,-	-,-	-,-	-,-	-,-
	Italian	C03	-,-	-,-	-,-	-,-	-,-
	Spanish	C04	-,-	-,-	-,-	-,-	-,-
	Czech	C05	-,-	-,-	-,-	-,-	-,-
	Dutch	C06	-,-	-,-	-,-	-,-	-,-
	Polish	C07	-,-	-,-	-,-	-,-	-,-
Data entry via touchs	creen						
·	without	E00	~	<b>V</b>			
	with	E01			V	V	V
R-PE test current for i	protective conductor measurement						
	200 mA	G00	<b>V</b>				
	200 mA and 10 A <sup>1)</sup> (not in combination with G02)	G01		/	~	/	
	200 mA and 25 A	G02					<b>/</b>
Connection for 2 <sup>nd</sup> tes		UUZ					
Connection for 2 tes	without	H00	~	~			
	with	H01			~	~	~
DVM function (digital v	oltmeter) with 2 additional measurement inputs, COM-V	1101					
DVIVI IUIICIIOII (UIGIIAI V	, , , , , , , , , , , , , , , , , , , ,	IOO	~	~			
	without	100	•	•			
0	with	101					
Connection for applica	•	100					.,
	without	J00	<b>/</b>	/	<b>/</b>	/	V
	with	J01					
Additional test sequen							
	without	KA00		<b>✓</b>	<b>✓</b>	<b>✓</b>	
	IEC 60601	KA01	285,-	285,-	285,-	285,-	285,-
Database expansion	without	KB00	<b>✓</b>	<b>✓</b>			
	with (corresponds to Z853R – SECUTEST DB+)	KB01	535,-	535,-		<b>✓</b>	<b>✓</b>
Database Comfort	without	KD00					
	with (corresponds to Z853S – SECUTEST DB COMFORT)	KD01	450,-	450,-	450,-	450,-	<b>/</b>
Bluetooth	without	M00	<b>/</b>	<b>/</b>	~	<b>/</b>	<b>/</b>
	with	M01	90,-	90,-	90,-	90,-	90,-
DAkkS calibration cer	tificate (language combinations)			-			
	D-GB-F	P00	-,-	-,-	-,-	-,-	-,-
	D-GB-PL	P01	-,-	-,-	-,-	-,-	-,-
			,	,	,	,	
	D-GB-IT	P02					
DAkkS calibration certif	D-GB-IT icate (recalibration)	P02	-,- 235,-	-,- 235,-	-,- 235,-	-,- 235,-	-,- 235,-

<sup>&</sup>lt;sup>1)</sup> 10 A/25 A-R<sub>PE</sub> mesasurements are only possible with line voltages of 115 V/ 230 V and line frequencies of 50 Hz/60 Hz.

### Sample order SECUTEST BASE10 with English user interface:

M7050 AA02 C01 G01 (highlighted features (in this case boldface, with gray background in the table) belong to the fixed basic equipment of SECUTEST BASE10, the other features can be selected as desired)

AA02: Device variant SECUTEST BASE10; C01: user interface, keyboard layout and test sequences in English; G01: R-PE test current for protective conductor measurement: 200 mA and 10 A

# SECUTEST BASE / PRO and SECULIFE ST BASE(25) Test Instruments for Measuring Electrical Safety of Devices

#### **Order Information for Accessories**

Designation	Туре	Article number
Mains power cable		
Cable set for connecting test instruments		
to the mains without using a an earthing		
contact outlet, and for connecting DUTs.		
Consists of coupling socket with 3 perma-		
nently connected cables, 3 measurement		
cables, 3 plug-on pick-up clips and 2 plug-		
on test probes.	KS13	GTY3624065P01
Adaptor for toeting 2 phase current con	cumore	
Adapter for testing 3-phase current cons Adapter for connecting DUTs:	Sumers	
3-pole 16 A, 5-pole 16 A + 32 A,		
5 ea. 4 mm socket		
- For all tests without line voltage		
at single and 3-phase electrical devices		
- for differential current measurements		
(direct or differential current method)	CEE Adapter	Z745A
16 A / 32 A 3-phase current adapter (test case)		
- For all tests without line voltage at single		
and 3-phase electrical devices		
- For tests at single		
and 3-phase extension cords		
<ul> <li>For differential current measurements</li> </ul>		
(direct method)		
für leakage current measurements in		
accordance with differential current	D	
method <sup>1</sup>	AT3-III-E D	Z745S
Test adapter for tests on devices with		
CEE16 and CEE32 connections	D 1	
(load rating of max 20 A)	AT3-IIS <sup>D 1</sup>	Z745T
same as AT3-II-S, however, with a load	4TO U 000 D 1	77.451/
rating of 32 A	AT3-II S32 <sup>D 1</sup>	Z745X
3-phase 16 A differential current adapter	AT16-DI	Z750A
3-phase 32 A differential current adapter	AT32-DI	Z750B
Test adapter with single and 3-phase plug		
connectors up to CEE 32A		
- For all tests without line voltage at single		
and 3-phase electrical devices		
- For tests at single	\/I OF	77.45\\\
and 3-phase extension cords	VL2E	Z745W
Adapter cable CEE 16 A 5-pin plug red on	A -l t t - l -	
CEE 32 A 5-pin coupling red, 0.5 m, 5 x 1.5 mm <sup>2</sup>	Adapter cable	77505
2.1.3 [][[[]	CEE16/CEE32	Z750F
Adapter for testing single-phase extensi	on cables	
Adapter for testing single-phase extension		
cables including earth contact and inlet		7700/
plug inserts	EL1	Z723A
Plug insert for using adapter EL1		
in Switzerland	PRO-CH	GTZ3225000R0001
Adapter for testing welding units		
Test adapter in combination with		
SECUTEST for testing welding units per		
DIN EN 60974-4:2007.		
The peak-value rectifier in the SECULOAD-		
N uses the 1N4007 rectifier diode recom-		
mended in the standard.		
This is a mains rectifier diode which, due to		
its design, is only suitable for voltage		
sources with low cycle rates within the		
range of the line frequency, or voltage		
sources with conventional transformer.		
		1
Includes 4 measurement cables and 2 alli-		

Designation	Туре	Article number			
Calibration adapter					
Calibration adapter for test instruments per DIN VDE 0701-0702/IEC 62353 (VDE 0751) (max. 200 mA) cannot be					
used for 10 A protective conductor test					
current	SECU-cal 10	Z715A			
Probe cable					
Probe cable with test probe and 2 m probe cable (not coiled), 300 V CAT II 16 A	SK2	Z745D			
Probe cable with test probe and 2 m probe cable (coiled), 300 V CAT II 16 A	SK2W	Z745N			
5 m probe cable for protective conductor	OVE	77.450			
measurement, 300 V CAT II 16 A	SK5 Z745G	Z7450			
Brush probe  Multiple probe connector for connecting 5  • 4 mm and 5 • 2 mm test probes to measure multiple touchable housing parts or		Z745G			
application parts.  Cable set (1 pair of measuring cables) 1.2 m, with VDE-GS sign 1000 V/CAT III 1 A, 600 V/CAT IV 1 A, 1000 V/CAT II 16 A*	SV5 KS17-2	Z745J GTY3620034P0002			
2 each in plastic bag, diameter 4 mm, length 1.0 m, 1000 V CAT III, 19 A, blue	Cable set blue	Z746A			
2 each in plastic bag, diameter 4 mm, length 1.0 m, 1000 V CAT III, 19 A, black/red	Cable set bw/rd	Z746B			
Clip-on current sensor for SECUTEST PR	O/SECULIFE ST BA	SE(25)			
Clip-on current sensor, can be set to 1 mA to 15 A or 1 A to 150 A,					
frequency range: 45 65 500 Hz, 1 mV/mA and 1 mV/A	WZ12C <sup>D)</sup>	Z219C			
Leakage current clamp 0.1 mA 25 mA, 100 mV/mA	SECUTEST CLIP D)	Z745H			
Town and the control DDO	VOCALILIES OF DAC	F/OF\			
Temperature sensors for SECUTEST PRO Pt100 temperature sensor for surface and immersion measurement, -40 to +500 °C	Z3409	GTZ3409000R0001			
Pt1000 temperature sensor for measurement in gases and liquids,	TF000	71004			
-50 +220 °C Pt100 oven sensor,	TF220	Z102A			
Pt100, -50 +550 °C	TF550	GTZ3408000R0001			
Sounding pipe oil temperature sensor, Pt1000 class B, –50+500 °C, sensor 3 mm dia. x 810 mm length	TF400CAR	Z102C			
Pouches and Cases Carrying pouch for SECUTEST BASE(10)/ PRO/SECULIFE ST BASE	F2000 <sup>D</sup>	Z700D			
Carrying pouch big for tester sets	F2020	Z700F			
Universal carrying pouch with flexible divider and display protection for SECUTEST BASE(10)/PRO/SECULIFE ST BASE	F2010	Z700G			
Plastic system case	SORTIMO L-BOXX	Z503D			
Foam insert for SORTIMO L-BOXX with divider for SECUTEST BASE(10)/PRO/SECULIFE ST BASE	Foam SORTIMO L-BOXX Secutest4	Z701D			
Foam insert for SORTIMO L-BOXX GM with	Foam SORTIMO	77045			
divider for adapters	L-BOXX Adapter	Z701E			

# **Test Instruments for Measuring Electrical Safety of Devices**

Designation	Туре	Article number
Data Storage		
Database expansion for SECUTEST		
BASE(10): data import, sequence import,		
Remote	SECUTEST DB+	Z853R
Database extension "comfort" for SECUT- EST BASE(10)/PRO/SECULIFE ST BASE(25) Entry option for test interval and medical device, shifting of test objects, Touch Edit,		
Quick Edit, sending of test result (to interface), Autostore		
Please indicate the SECUTEST serial num-	SECUTEST DB	
ber for placing an order.	comfort	Z853S
		-
Report Generating Accessories		
RFID-System		
RFID read/write for USB connection		
(frequency: 13.56 MHz)	SCANBASE RFID	Z751E
RFID tags per ISO 15693, dia. approx.		
22 mm, self-adhesive, 500 pcs.	Z751R	Z751R
RFID tags per ISO 15693, dia. approx.		
30 mm, thickness 2 – 3 mm with 3 –	77540	77540
4 mm hole 500 pcs.	Z751S	Z751S
RFID tags per ISO 15693, pigeon ring,	77547	77547
dia. approx. 7.5 mm, 250 pcs.	Z751T	Z751T
Barcode reader	7754 A	7754 4
Barcode scanner for USB connection	Z751A	Z751A
Barcode printer		T
Barcode and label printer including soft-		
ware, for USB connection to the PC or test instrument SECUTEST BASE(10)	Z721D	Z721D
Label set for Z721D barcode and label	LIZIU	LIZIU
printer (quantity x width: 3 x 24, 1 x 18, 1 x 9 mm, length: 8 m each)	Z722D	Z722D
Label set for Z721D barcode and label printer (qty. x width: 5 x 18 mm, 8 m long each)	Z722E	Z722E
Thermal printer		
Thermal printer for printing out test re- ports; incl. manual on CD, lithium battery, power supply adapter, mains cable, USB		
cable, 1 role of thermal paper	Z721S	Z721S
Thermo paper for Z721S; 10 roll of thermal paper, Ø 12/50mm, 30 m x 112 mm, coating outside	Z722S	Z722S
See also separate ID systems data sheet re and printers.	garding RFID scann	ers, barcode scanners

D data sheet available

For additional information regarding accessories please refer to

- Measuring Instruments and Testers catalog
- www.gossenmetrawatt.com

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only with SECUTEST PRO (Feature I01) or SECULIFE ST BASE